



## MOSFET

Metal Oxide Semiconductor Field Effect Transistor

### CoolMOS™ C6 600V

600V CoolMOS™ C6 Power Transistor  
IPx60R600C6

## Data Sheet

Rev. 2.5  
Final

Power Management & Multimarket

## 600V CoolMOS™ C6 Power Transistor

IPD60R600C6, IPB60R600C6  
IPP60R600C6, IPA60R600C6

### 1 Description

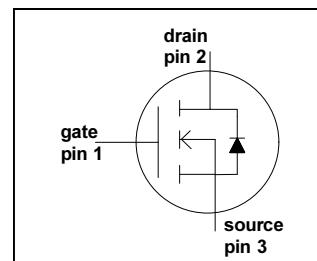
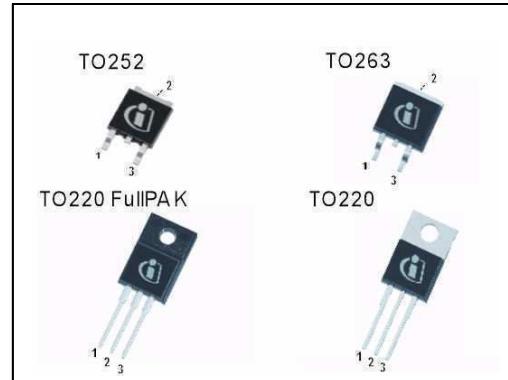
CoolMOS™ is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies. CoolMOS™ C6 series combines the experience of the leading SJ MOSFET supplier with high class innovation. The offered devices provide all benefits of a fast switching SJ MOSFET while not sacrificing ease of use. Extremely low switching and conduction losses make switching applications even more efficient, more compact, lighter, and cooler.

#### Features

- Extremely low losses due to very low FOM  $R_{DS(on)} \cdot Q_g$  and  $E_{oss}$
- Very high commutation ruggedness
- Easy to use/drive
- JEDEC<sup>1)</sup> qualified, Pb-free plating
- Halogen free mold compound

#### Applications

PFC stages, hard switching PWM stages and resonant switching PWM stages for e.g. PC Silverbox, Adapter, LCD & PDP TV, Lighting, Server, Telecom and UPS.



**Table 1 Key Performance Parameters**

Parameter	Value	Unit
$V_{DS} @ T_{j,max}$	650	V
$R_{DS(on),max}$	0.6	$\Omega$
$Q_{g,typ}$	20.5	nC
$I_{D,pulse}$	19	A
$E_{oss} @ 400V$	1.9	$\mu J$
Body diode $dI/dt$	500	A/ $\mu s$

Type / Ordering Code	Package	Marking	Related Links
IPB60R600C6	PG-T0263	6R600C6	<a href="#">IFX C6 Product Brief</a>
IPD60R600C6	PG-T0252		<a href="#">IFX C6 Portfolio</a>
IPP60R600C6	PG-T0220		<a href="#">IFX CoolMOS Webpage</a>
IPA60R600C6	PG-T0220 FullPAK		<a href="#">IFX Design tools</a>

1) J-STD20 and JESD22

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## 2 Maximum ratings

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified.

**Table 2 Maximum ratings**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Continuous drain current <sup>1)</sup>	$I_D$	-	-	7.3	A	$T_C = 25^\circ\text{C}$
				4.6		$T_C = 100^\circ\text{C}$
Pulsed drain current <sup>2)</sup>	$I_{D,\text{pulse}}$	-	-	19	A	$T_C = 25^\circ\text{C}$
Avalanche energy, single pulse	$E_{AS}$	-	-	133	mJ	$I_D = 1.3 \text{ A}, V_{DD} = 50 \text{ V}$ (see table 21)
Avalanche energy, repetitive	$E_{AR}$	-	-	0.2		$I_D = 1.3 \text{ A}, V_{DD} = 50 \text{ V}$
Avalanche current, repetitive	$I_{AR}$	-	-	1.3	A	
MOSFET dv/dt ruggedness	dv/dt	-	-	50	V/ns	$V_{DS} = 0 \dots 480 \text{ V}$
Gate source voltage	$V_{GS}$	-20	-	20	V	static
		-30		30		AC ( $f > 1 \text{ Hz}$ )
Power dissipation for TO-220, TO-252, TO-263	$P_{tot}$	-	-	63	W	$T_C = 25^\circ\text{C}$
Power dissipation for TO-220 FullPAK	$P_{tot}$	-	-	28	W	$T_C = 25^\circ\text{C}$
Operating and storage temperature	$T_j, T_{stg}$	-55	-	150	°C	
Mounting torque TO-220		-	-	60	Ncm	M3 and M3.5 screws
Mounting torque TO-220 FullPAK				50		M2.5 screws
Continuous diode forward current	$I_S$	-	-	6.3	A	$T_C = 25^\circ\text{C}$
Diode pulse current <sup>2)</sup>	$I_{S,\text{pulse}}$	-	-	19	A	$T_C = 25^\circ\text{C}$
Reverse diode dv/dt <sup>3)</sup>	dv/dt	-	-	15	V/ns	$V_{DS} = 0 \dots 400 \text{ V}, I_{SD} \leq I_D, T_j = 25^\circ\text{C}$ (see table 22)
Maximum diode commutation speed <sup>3)</sup>	di/dt			500	A/μs	

1) Limited by  $T_{j,\text{max}}$ . Maximum duty cycle D=0.75

2) Pulse width  $t_p$  limited by  $T_{j,\text{max}}$

3) Identical low side and high side switch with identical  $R_G$

## Thermal characteristics

### 3 Thermal characteristics

**Table 3 Thermal characteristics TO-220 (IPP60R600C6)**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	$R_{thJC}$	-	-	2.0	°C/W	
Thermal resistance, junction - ambient	$R_{thJA}$	-	-	62		leaded
Soldering temperature, wavesoldering only allowed at leads	$T_{sold}$	-	-	260	°C	1.6 mm (0.063 in.) from case for 10 s

**Table 4 Thermal characteristics TO-220FullPAK (IPA60R600C6)**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	$R_{thJC}$	-	-	4.5	°C/W	
Thermal resistance, junction - ambient	$R_{thJA}$	-	-	80		leaded
Soldering temperature, wavesoldering only allowed at leads	$T_{sold}$	-	-	260	°C	1.6 mm (0.063 in.) from case for 10 s

**Table 5 Thermal characteristics TO-263 (IPB60R600C6),TO-252 (IPD60R600C6)**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	$R_{thJC}$	-	-	2.0	°C/W	
Thermal resistance, junction - ambient	$R_{thJA}$	-	-	62		SMD version, device on PCB, minimal footprint
			35			SMD version, device on PCB, 6cm² cooling area <sup>1)</sup>
Soldering temperature, wave- & reflow soldering allowed	$T_{sold}$	-	-	260	°C	reflow MSL1

1) Device on 40mm\*40mm\*1.5mm one layer epoxy PCB FR4 with 6cm² copper area (thickness 70µm) for drain connection. PCB is vertical without air stream cooling.

## Electrical characteristics

## 4 Electrical characteristics

Electrical characteristics, at  $T_j=25\text{ }^\circ\text{C}$ , unless otherwise specified.

**Table 6 Static characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(\text{BR})\text{DSS}}$	600	-	-	V	$V_{\text{GS}}=0\text{ V}, I_{\text{D}}=0.25\text{ mA}$
Gate threshold voltage	$V_{\text{GS}(\text{th})}$	2.5	3	3.5		$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=0.20\text{mA}$
Zero gate voltage drain current	$I_{\text{DSS}}$	-	-	1	$\mu\text{A}$	$V_{\text{DS}}=600\text{ V}, V_{\text{GS}}=0\text{ V}, T_j=25\text{ }^\circ\text{C}$
		-	10	-		$V_{\text{DS}}=600\text{ V}, V_{\text{GS}}=0\text{ V}, T_j=150\text{ }^\circ\text{C}$
Gate-source leakage current	$I_{\text{GSS}}$	-	-	100	nA	$V_{\text{GS}}=20\text{ V}, V_{\text{DS}}=0\text{ V}$
Drain-source on-state resistance	$R_{\text{DS}(\text{on})}$	-	0.54	0.60	$\Omega$	$V_{\text{GS}}=10\text{ V}, I_{\text{D}}=2.4\text{ A}, T_j=25\text{ }^\circ\text{C}$
		-	1.40	-		$V_{\text{GS}}=10\text{ V}, I_{\text{D}}=2.4\text{A}, T_j=150\text{ }^\circ\text{C}$
Gate resistance	$R_{\text{G}}$	-	17.5	-	$\Omega$	$f=1\text{ MHz, open drain}$

**Table 7 Dynamic characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Input capacitance	$C_{\text{iss}}$	-	440	-	pF	$V_{\text{GS}}=0\text{ V}, V_{\text{DS}}=100\text{ V}, f=1\text{ MHz}$
Output capacitance	$C_{\text{oss}}$	-	30	-		$V_{\text{GS}}=0\text{ V}, V_{\text{DS}}=\dots480\text{ V}$
Effective output capacitance, energy related <sup>1)</sup>	$C_{\text{o(er)}}$	-	21	-		$I_{\text{D}}=\text{constant}, V_{\text{GS}}=0\text{ V} V_{\text{DS}}=\dots480\text{V}$
Effective output capacitance, time related <sup>2)</sup>	$C_{\text{o(tr)}}$	-	88	-		
Turn-on delay time	$t_{\text{d(on)}}$	-	12	-	ns	$V_{\text{DD}}=400\text{ V}, V_{\text{GS}}=13\text{ V}, I_{\text{D}}=3\text{ A}, R_{\text{G}}=6.8\text{ }\Omega$
Rise time	$t_{\text{r}}$	-	9	-		(see table 20)
Turn-off delay time	$t_{\text{d(off)}}$	-	80	-		
Fall time	$t_{\text{f}}$	-	13	-		

1)  $C_{\text{o(er)}}$  is a fixed capacitance that gives the same stored energy as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 80%  $V_{(\text{BR})\text{DSS}}$

2)  $C_{\text{o(tr)}}$  is a fixed capacitance that gives the same charging time as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 80%  $V_{(\text{BR})\text{DSS}}$

**Electrical characteristics**
**Table 8 Gate charge characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Gate to source charge	$Q_{gs}$	-	2.5	-	nC	$V_{DD}=480 \text{ V}, I_D=3.0 \text{ A}, V_{GS}=0 \text{ to } 10 \text{ V}$
Gate to drain charge	$Q_{gd}$	-	10.5	-		
Gate charge total	$Q_g$	-	20.5	-		
Gate plateau voltage	$V_{plateau}$	-	5.4	-		

**Table 9 Reverse diode characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Diode forward voltage	$V_{SD}$	-	0.9	-	V	$V_{GS}=0 \text{ V}, I_F=3.0 \text{ A}, T_j=25 \text{ °C}$
Reverse recovery time	$t_{rr}$	-	250	-		
Reverse recovery charge	$Q_{rr}$	-	2.1	-		
Peak reverse recovery current	$I_{rrm}$	-	16	-		

## 5 Electrical characteristics diagrams

Electrical characteristics diagrams

Table 10

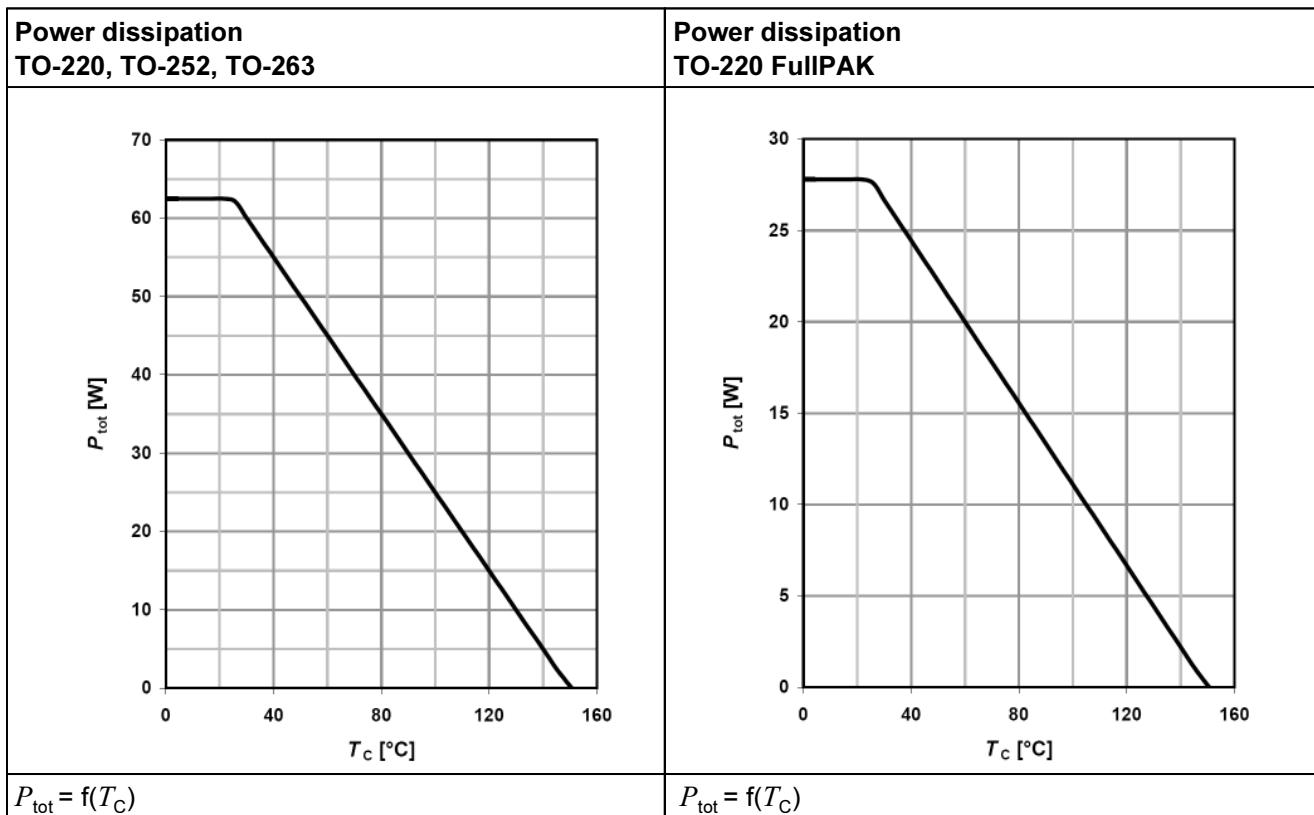
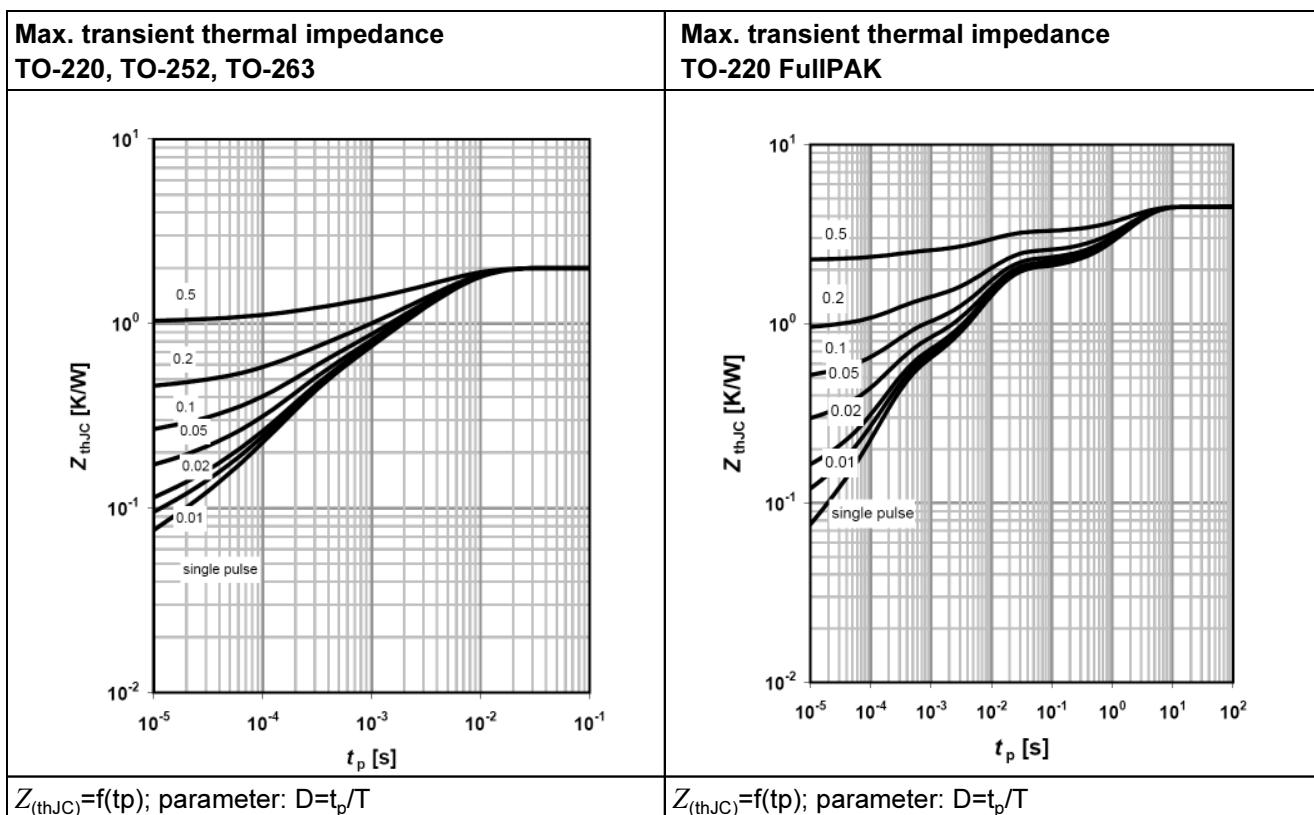


Table 11

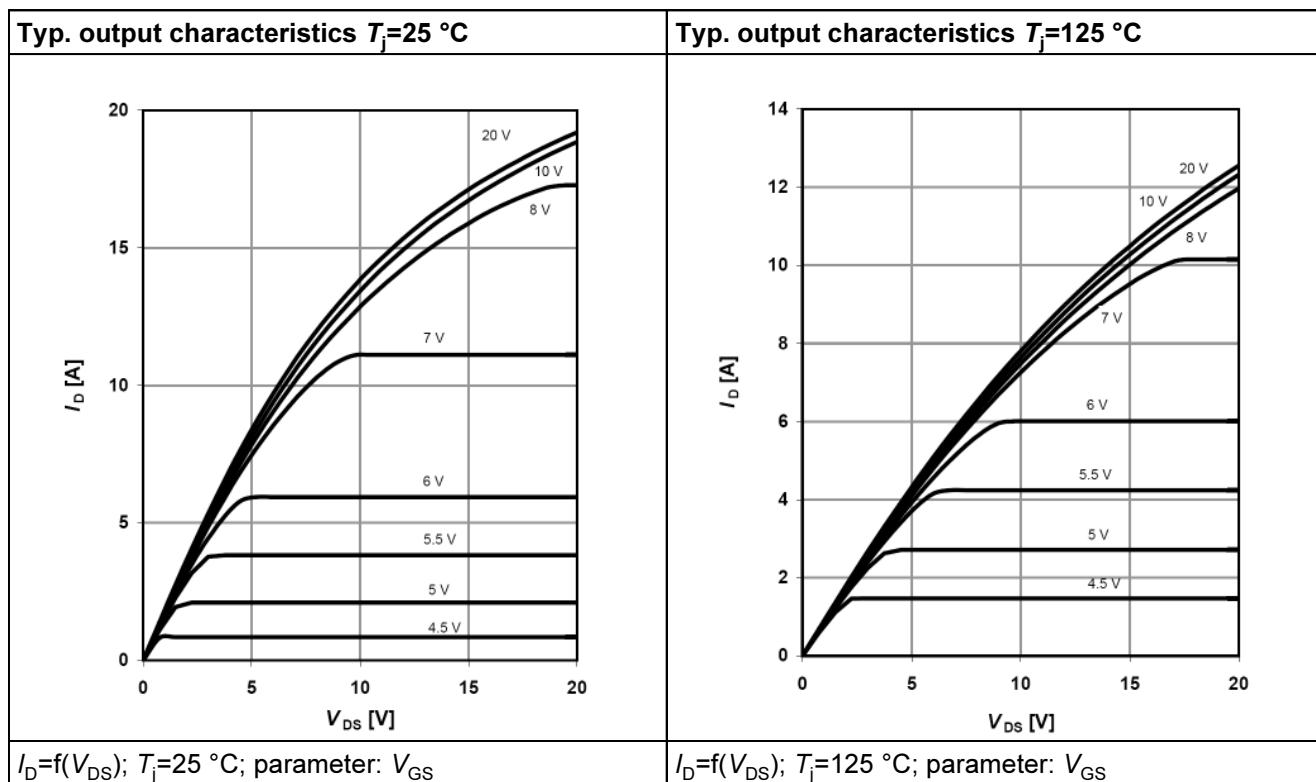
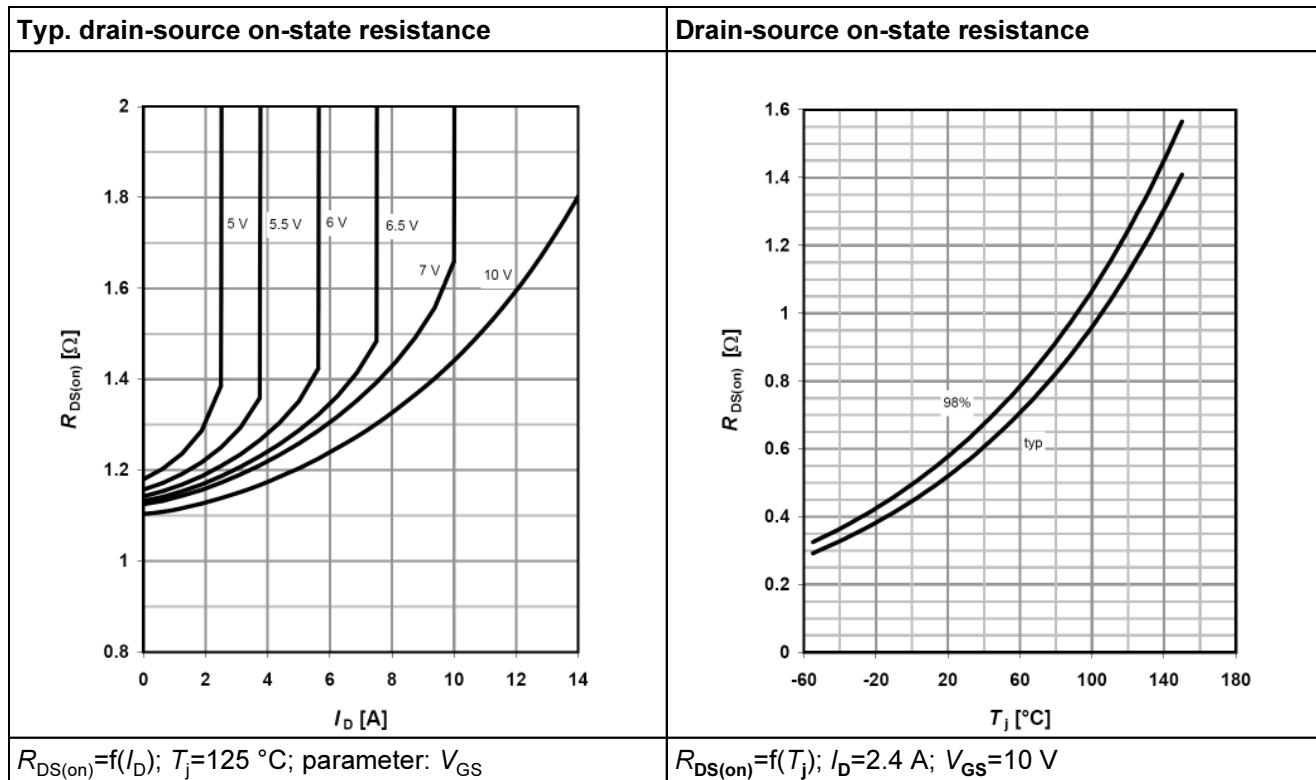


**Electrical characteristics diagrams**
**Table 12**

Safe operating area $T_C=25\text{ }^\circ\text{C}$ TO-220, TO-252, TO-263	Safe operating area $T_C=25\text{ }^\circ\text{C}$ TO-220 FullPAK
<p><math>I_D=f(V_{DS})</math>; <math>T_C=25\text{ }^\circ\text{C}</math>; D=0; parameter <math>t_p</math></p>	<p><math>I_D=f(V_{DS})</math>; <math>T_C=25\text{ }^\circ\text{C}</math>; D=0; parameter <math>t_p</math></p>

**Table 13**

Safe operating area $T_C=80\text{ }^\circ\text{C}$ TO-220, TO-252, TO-263	Safe operating area $T_C=80\text{ }^\circ\text{C}$ TO-220 FullPAK
<p><math>I_D=f(V_{DS})</math>; <math>T_C=80\text{ }^\circ\text{C}</math>; D=0; parameter <math>t_p</math></p>	<p><math>I_D=f(V_{DS})</math>; <math>T_C=80\text{ }^\circ\text{C}</math>; D=0; parameter <math>t_p</math></p>

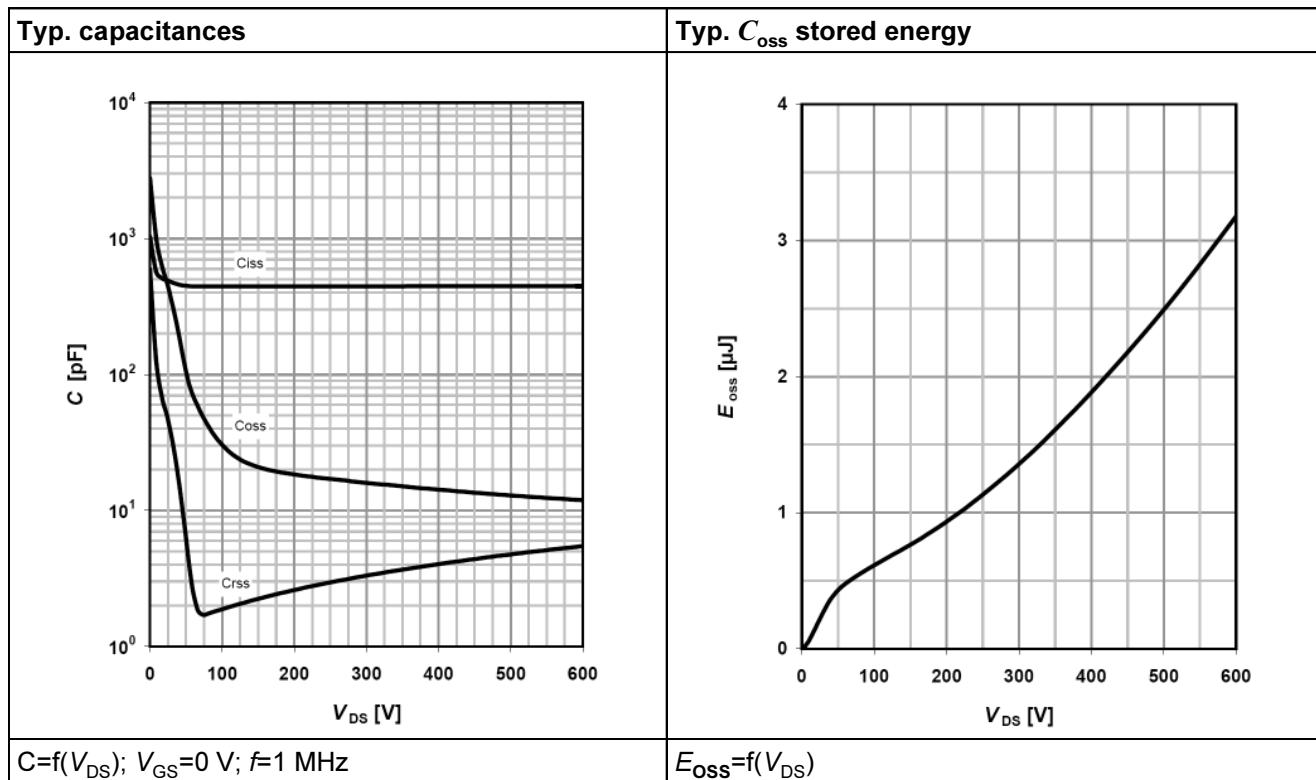
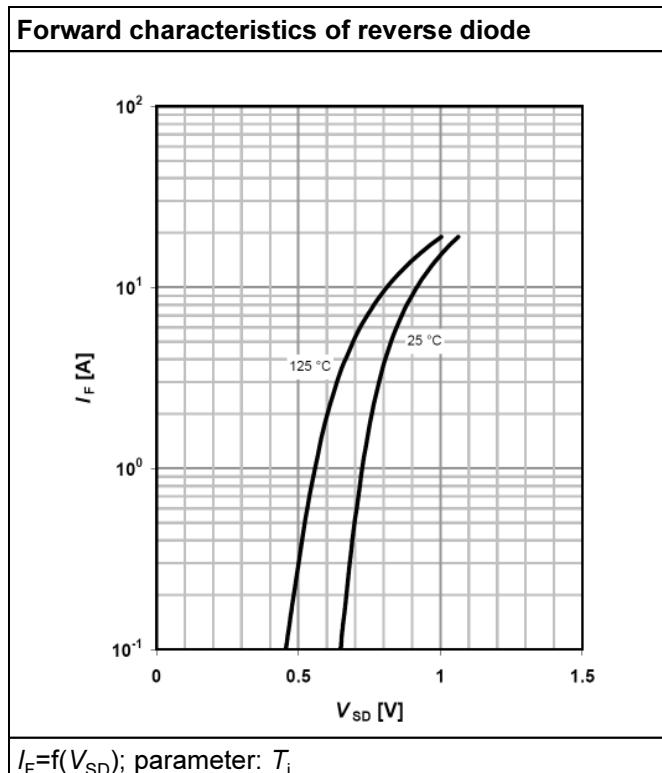
**Electrical characteristics diagrams**
**Table 14**

**Table 15**


**Electrical characteristics diagrams**
**Table 16**

Typ. transfer characteristics	Typ. gate charge
$I_D = f(V_{GS})$ ; $V_{DS} = 20V$	$V_{GS} = f(Q_{gate})$ , $I_D = 3.0A$ pulsed

**Table 17**

Avalanche energy	Drain-source breakdown voltage

**Electrical characteristics diagrams**
**Table 18**

**Table 19**


## 6 Test circuits

**Table 20** Switching times test circuit and waveform for inductive load

Switching times test circuit for inductive load	Switching time waveform

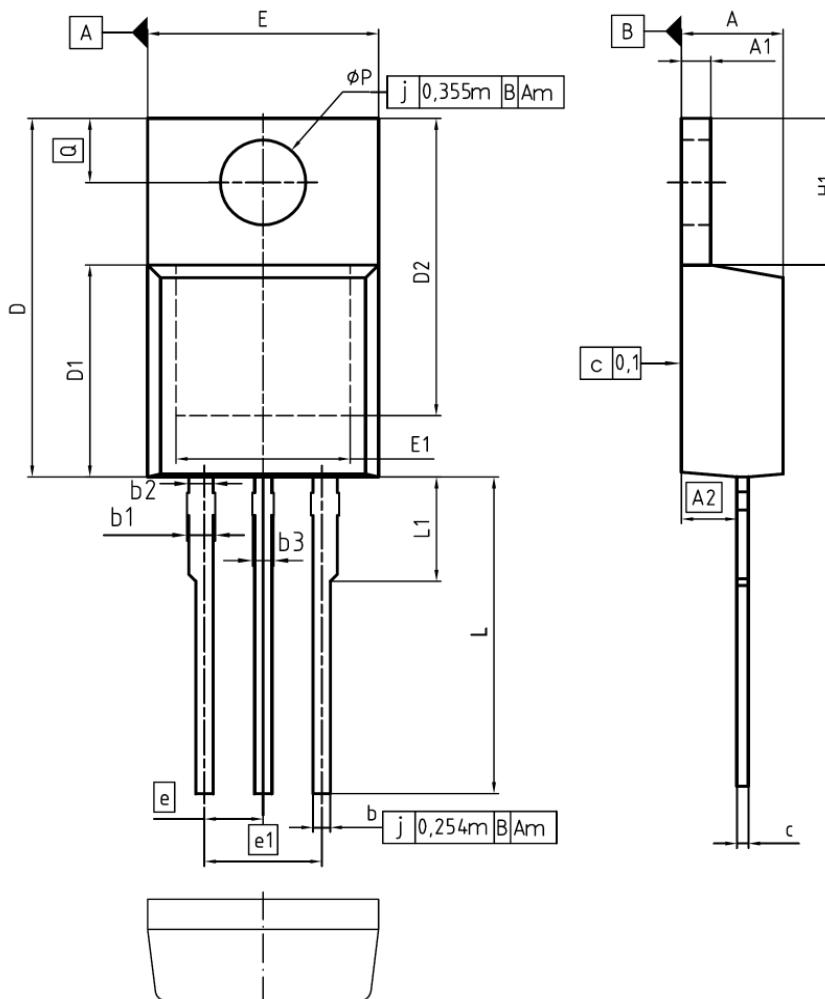
**Table 21** Unclamped inductive load test circuit and waveform

Unclamped inductive load test circuit	Unclamped inductive waveform

**Table 22** Test circuit and waveform for diode characteristics

Test circuit for diode characteristics	Diode recovery waveform
<p><math>R_{G1} = R_{G2}</math></p>	

## 7 Package outlines



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.30	4.57	0.169	0.180
A1	1.17	1.40	0.046	0.055
A2	2.15	2.72	0.085	0.107
b	0.65	0.86	0.026	0.034
b1	0.95	1.40	0.037	0.055
b2	0.95	1.15	0.037	0.045
b3	0.65	1.15	0.026	0.045
c	0.33	0.60	0.013	0.024
D	14.81	15.95	0.583	0.628
D1	8.51	9.45	0.335	0.372
D2	12.19	13.10	0.480	0.516
E	9.70	10.36	0.382	0.408
E1	6.50	8.60	0.256	0.339
e	2.54		0.100	
e1	5.08		0.200	
N	3		3	
H1	5.90	6.90	0.232	0.272
L	13.00	14.00	0.512	0.551
L1	-	4.80	-	0.189
φP	3.60	3.89	0.142	0.153
Q	2.60	3.00	0.102	0.118

DOCUMENT NO.	ZBB00003318
SCALE	0 2.5 0 2.5 5mm
EUROPEAN PROJECTION	
ISSUE DATE	23-08-2007
REVISION	05

Figure 1 Outlines TO-220, dimensions in mm/inches

## Package outlines

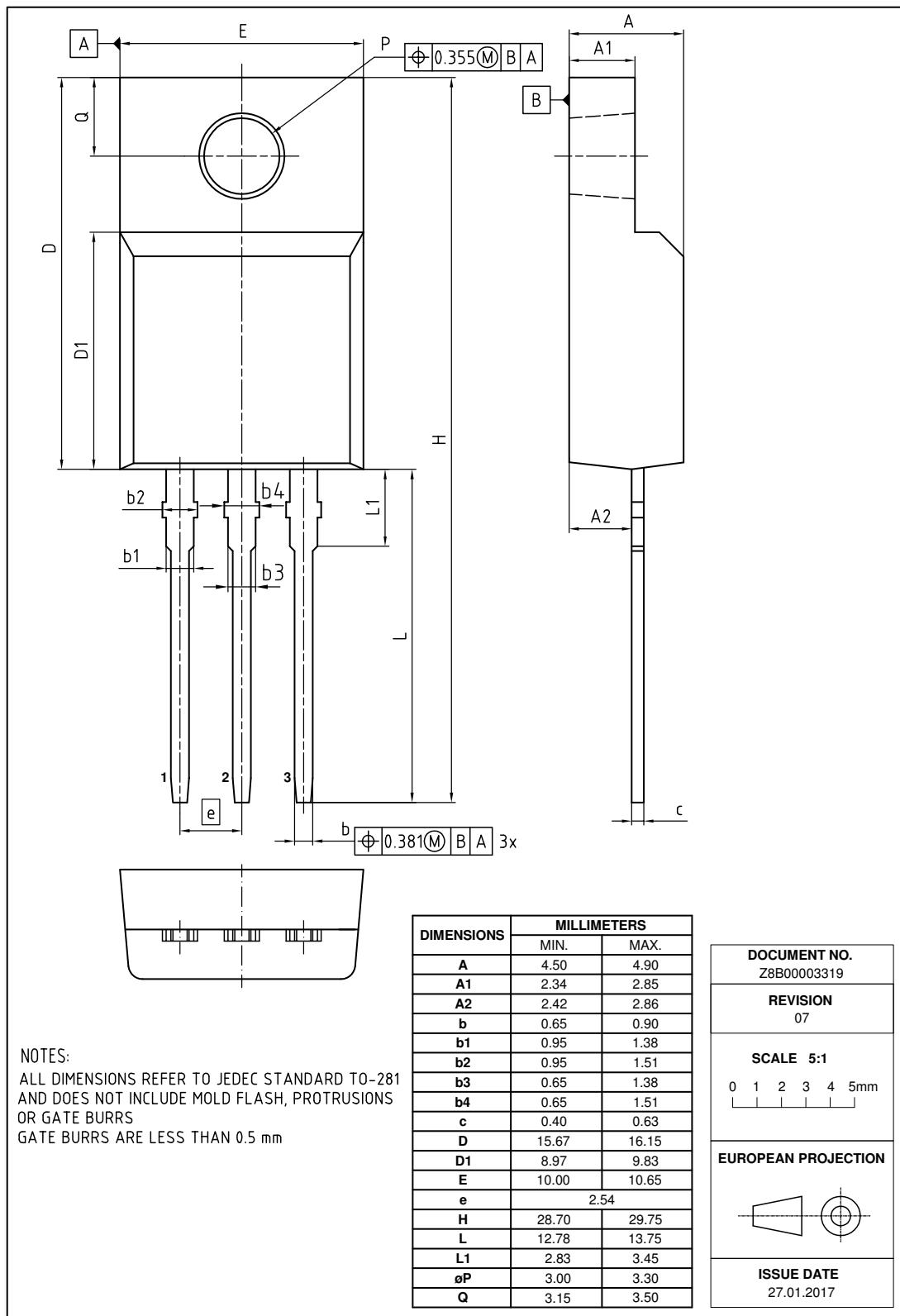
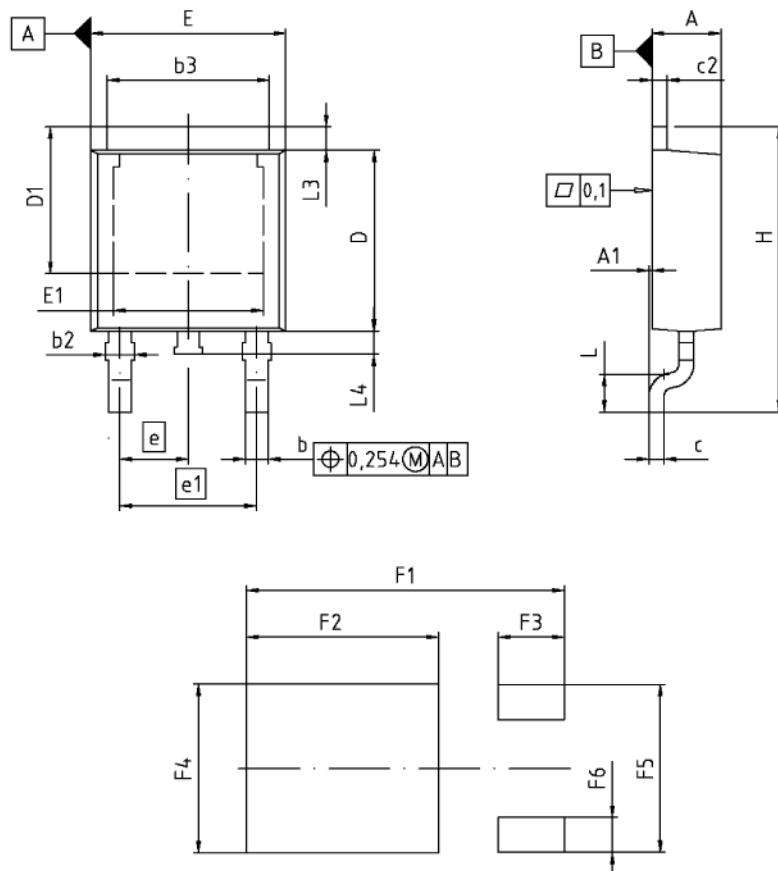


Figure 2 Outline PG-T0 220 FullPAK, dimensions in mm

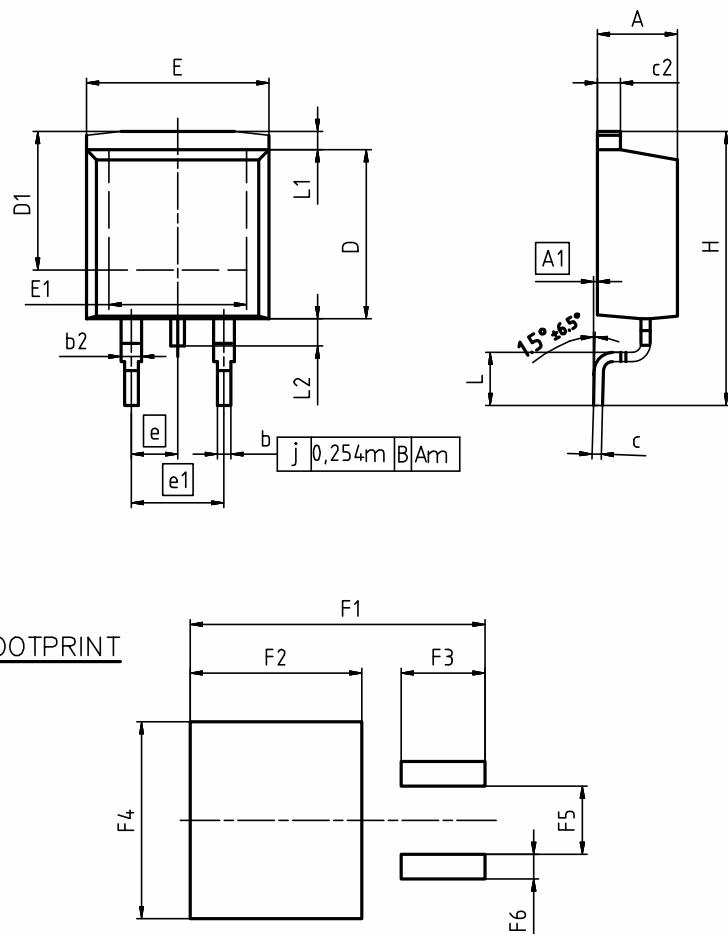


DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	2.16	2.41	0.085	0.095
A1	0.00	0.15	0.000	0.006
b	0.64	0.89	0.025	0.035
b2	0.65	1.15	0.026	0.045
b3	5.00	5.50	0.197	0.217
c	0.46	0.60	0.018	0.024
c2	0.46	0.98	0.018	0.039
D	5.97	6.22	0.235	0.245
D1	5.02	5.84	0.198	0.230
E	6.40	6.73	0.252	0.265
E1	4.70	5.21	0.185	0.205
e	2.29		0.090	
e1	4.57		0.180	
N	3		3	
H	9.40	10.48	0.370	0.413
L	1.18	1.70	0.046	0.067
L3	0.90	1.25	0.035	0.049
L4	0.51	1.00	0.020	0.039
F1	10.50	10.70	0.413	0.421
F2	6.30	6.50	0.248	0.256
F3	2.10	2.30	0.083	0.091
F4	5.70	5.90	0.224	0.232
F5	5.66	5.86	0.223	0.231
F6	1.10	1.30	0.043	0.051

DOCUMENT NO.	Z8B00003328
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EUROPEAN PROJECTION	
ISSUE DATE	19-10-2007
REVISION	03

Figure 3 Outlines TO-252, dimensions in mm/inches

## Package outlines



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.30	4.57	0.169	0.180
A1	0.00	0.25	0.000	0.010
b	0.85	0.85	0.026	0.033
b2	0.95	1.15	0.037	0.045
c	0.33	0.65	0.013	0.026
c2	1.17	1.40	0.046	0.055
D	8.51	9.45	0.335	0.372
D1	7.10	7.90	0.280	0.311
E	9.80	10.31	0.386	0.406
E1	6.50	8.60	0.256	0.339
e	2.54		0.100	
e1	5.08		0.200	
N	2		2	
H	14.61	15.88	0.575	0.625
L	2.29	3.00	0.090	0.118
L1	0.70	1.60	0.028	0.063
L2	1.00	1.78	0.039	0.070
F1	16.05	16.25	0.632	0.640
F2	9.30	9.50	0.366	0.374
F3	4.50	4.70	0.177	0.185
F4	10.70	10.90	0.421	0.429
F5	3.65	3.85	0.144	0.152
F6	1.25	1.45	0.049	0.057

DOCUMENT NO.	Z8B00003324
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EUROPEAN PROJECTION	
ISSUE DATE	30-08-2007
REVISION	01

Figure 4 Outlines TO-263, dimensions in mm/inches

## Revision History

IPx60R600C6

**Revision: 2018-03-06, Rev. 2.5**

### Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.0	2011-06-08	Release of final data sheet
2.1	2011-09-14	-
2.2	2015-02-11	PG-T0220 FullPAK package outline update (creation:2014-12-10)
2.3	2015-11-17	Added Halogen Free info. Valid for TO220FP and TO252 ONLY
2.4	2016-01-07	Corrected typo error. All packages are Halogen Free
2.5	2018-03-06	Outline PG-T0220 FullPAK update

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